Applicant(s)/Patent Under Application/Control No. Reexamination 09/695,636 DEGUCHI ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 2166 Joon H. Hwang **U.S. PATENT DOCUMENTS** Document Number Date Classification Name Country Code-Number-Kind Code MM-YYYY Deguchi, Yuichiro 707/104.1 US-6,578,047 06-2003 Α * 345/772 US-2002/0054119 05-2002 DOW et al. В С US-US-D US-Ε US-F US-G USн US-US-US-Κ US-US-**FOREIGN PATENT DOCUMENTS**

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